

LexisNexis IP Solutions

ICIC

Diana Schwarzenau
IP Sales Specialist DACH

- TotalPatent Update
 - Asian Content incl. MT
- PatentOptimizer Update
 - One click error report

- Over 6 million documents from China:
 - CN granted patents from 1985
 - CN patent applications from 1985
 - CN utility models from 1985
- Bibliographic collection:
 - Almost all documents contain English Titles
 - Almost all documents contain English Abstracts
- Full Text collection:
 - Over 6 million CN full text records with searchable Descriptions in English
 - Over 6 million CN full text records with searchable Claims in English
 - Machine translations available with 2 weeks of publication
- Image collection:
 - Over 5.5 million images
 - Approximately 6 million compressed PDFs with English bookmarks

- Approximately 24 million documents from Japan:
 - JP granted patents from 1977 to current
 - JP patent applications from 1973 to current
 - JP Utility Models from 1972 to current
- Bibliographic collection:
 - Almost 50% of documents contain English Titles
 - Over 50% contain English Abstracts
- Full Text collection:
 - Over 10 million JP full text records with searchable Descriptions
 - 100% contain searchable English language Claims
- Image collection:
 - Roughly 10 million images
 - Approximately 17 million compressed PDFs with English bookmarks

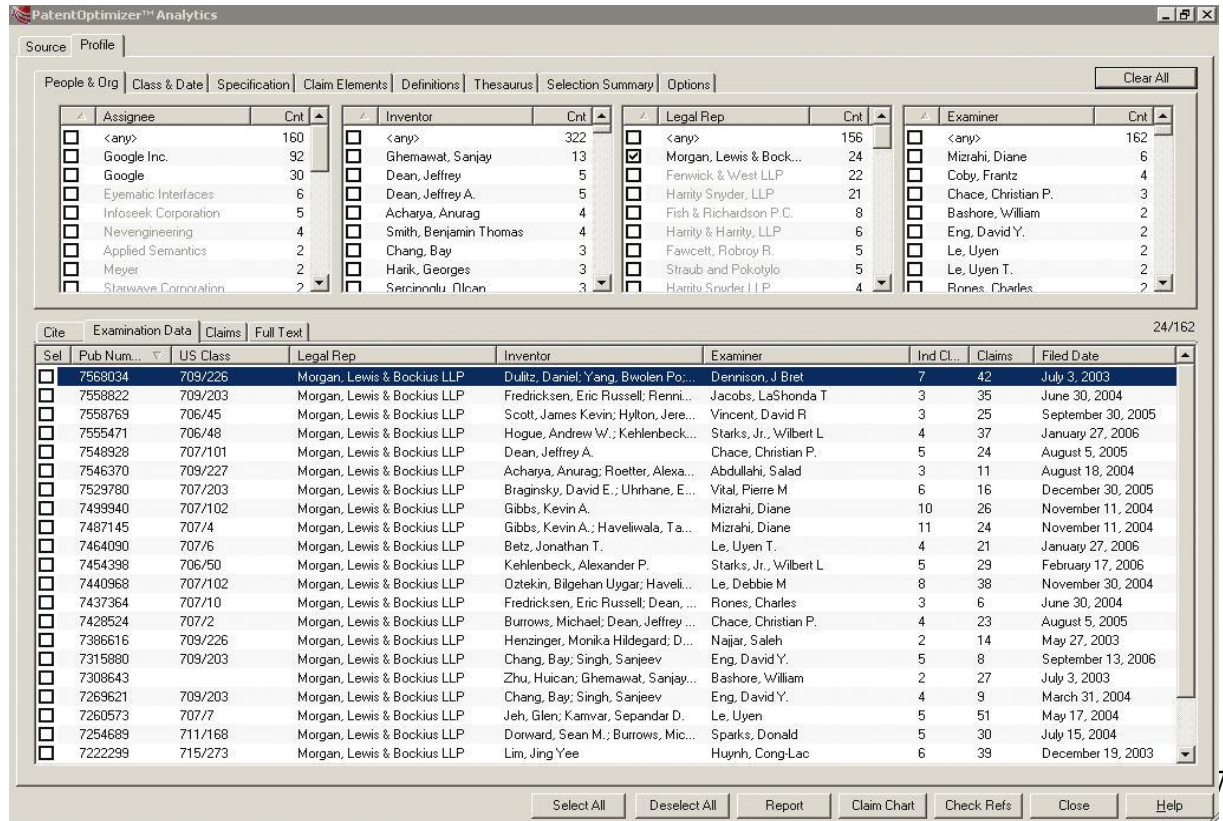
- Approximately 4.5 million documents from Korea:
 - KR granted patents from 1978
 - KR patent applications from 1978
- Bibliographic collection:
 - About 70% of all documents contain English Titles
 - Over 50% contain English Abstracts
- Full Text collection:
 - MT for frontfiles back to 2010
 - MT for whole collection until 1st quarter of 2013
- Image collection:
 - Over 3.2 million images

- Approximately 380.000 documents from India:
 - Indian granted patents from 1975
 - Indian patent applications from 1995

Development plans for Q4 2012:

- Full Text collection:
 - Indian granted patents from 1975 incl. Biblio, PDF, Clipped images, Drawings
 - Indian applications from 1995 incl. Biblio, PDF, Clipped images, Drawings
- Objective:
 - Increase the coverage of bibliographic data, abstract, full text, images and PDF to nearly 100%

- Draft consistent, concise, and well-tailored patent applications; serves also as a quality check for patents when drafting is outsourced
- Analyze single patent documents to identify potential areas of weakness
- Analyze complete patent portfolios to statistically diagnose claims in large portfolios, filter and rank patent documents by key metrics, generate claim charts and generate claim element lists, locate specific synonyms utilized as across an entire portfolio



The screenshot displays the PatentOptimizer Analytics software interface. The main window shows a table of patent data with columns for Cite, Pub Num, US Class, Legal Rep, Inventor, Examiner, Ind Cl., Claims, and Filed Date. The table is filtered to show patents assigned to Morgan, Lewis & Bockius LLP. The interface also includes a 'Profile' tab with sub-tabs for People & Org, Class & Date, Specification, Claim Elements, Definitions, Thesaurus, Selection Summary, and Options. The 'People & Org' sub-tab is active, showing a list of assignees, inventors, legal representatives, and examiners with their respective counts.

Cite	Pub Num	US Class	Legal Rep	Inventor	Examiner	Ind Cl.	Claims	Filed Date
7568034	709/226		Morgan, Lewis & Bockius LLP	Dulitz, Daniel; Yang, Bwolen Po...	Dennison, J Bret	7	42	July 3, 2003
7558822	709/203		Morgan, Lewis & Bockius LLP	Fredricksen, Eric Russell; Renn...	Jacobs, LaShonda T	3	35	June 30, 2004
7558769	706/45		Morgan, Lewis & Bockius LLP	Scott, James Kevin; Hyllon, Jere...	Vincent, David R	3	25	September 30, 2005
7555471	706/48		Morgan, Lewis & Bockius LLP	Hogue, Andrew W.; Kehlenbeck...	Starks, Jr., Wilbert L	4	37	January 27, 2006
7548928	707/101		Morgan, Lewis & Bockius LLP	Dean, Jeffrey A.	Chace, Christian P.	5	24	August 5, 2005
7546370	709/227		Morgan, Lewis & Bockius LLP	Acharya, Anurag; Roetter, Alex...	Abdullahi, Salad	3	11	August 18, 2004
7529780	707/203		Morgan, Lewis & Bockius LLP	Braginsky, David E.; Uhrhane, E...	Vital, Pierre M	6	16	December 30, 2005
7499940	707/102		Morgan, Lewis & Bockius LLP	Gibbs, Kevin A.	Mizrahi, Diane	10	26	November 11, 2004
7487145	707/4		Morgan, Lewis & Bockius LLP	Gibbs, Kevin A.; Haveliwala, Ta...	Mizrahi, Diane	11	24	November 11, 2004
7464090	707/6		Morgan, Lewis & Bockius LLP	Betz, Jonathan T.	Le, Uyen T.	4	21	January 27, 2006
7454398	706/50		Morgan, Lewis & Bockius LLP	Kehlenbeck, Alexander P.	Starks, Jr., Wilbert L	5	29	February 17, 2006
7440968	707/102		Morgan, Lewis & Bockius LLP	Oztekin, Bilgehan Uygar; Haveli...	Le, Debbie M	8	38	November 30, 2004
7437364	707/10		Morgan, Lewis & Bockius LLP	Fredricksen, Eric Russell; Dean...	Rones, Charles	3	6	June 30, 2004
7428524	707/2		Morgan, Lewis & Bockius LLP	Burrows, Michael; Dean, Jeffrey...	Chace, Christian P.	4	23	August 5, 2005
7386616	709/226		Morgan, Lewis & Bockius LLP	Henzinger, Monika Hildegard; D...	Najjar, Saleh	2	14	May 27, 2003
7315880	709/203		Morgan, Lewis & Bockius LLP	Chang, Bay; Singh, Sanjeev	Eng, David Y.	5	8	September 13, 2006
7308643			Morgan, Lewis & Bockius LLP	Zhu, Huican; Ghemawat, Sanjay...	Bashore, William	2	27	July 3, 2003
7269621	709/203		Morgan, Lewis & Bockius LLP	Chang, Bay; Singh, Sanjeev	Eng, David Y.	4	9	March 31, 2004
7260573	707/7		Morgan, Lewis & Bockius LLP	Jeh, Glen; Kamvar, Sepandar D.	Le, Uyen	5	51	May 17, 2004
7254689	711/168		Morgan, Lewis & Bockius LLP	Dorward, Sean M.; Burrows, Mic...	Sparks, Donald	5	30	July 15, 2004
7222299	715/273		Morgan, Lewis & Bockius LLP	Lim, Jing Yee	Huyrh, Cong-Lac	6	39	December 19, 2003

One-click error reports containing comprehensive analysis data generated from the entire suite of PatentOptimizer™ tools, including:

- ✓ Claim Errors
- ✓ Word/Element Counts
- ✓ Claim Tree
- ✓ Claim elements lacking proper antecedent basis, support in the disclosure or support in the drawings
- ✓ Case Annotations
- ✓ Terms/phrases with potentially problematic language
- ✓ Title/Abstract Errors
- ✓ Acronym Errors
- ✓ Parts having inconsistent labels, Parts with Multiple Numbers
- ✓ Missing Part Numbers
- ✓ Measurement expressions having incorrect conversions
- ✓ References with Post-Issuance Activity



Diana



Raoul

**We are at your disposal for questions or information,
Looking forward to making your acquaintance.
Kind regards,
LexisNexis IP Solutions**